

1P20Rscd Form 1006 JUL 2006
PATENTIN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of:

Takayuki NIKAIDO et al

National phase of International Application No. PCT/JP2004/019498

International filing date: December 27, 2004

For: REFLOW FURNACE

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

Pursuant to the requirements of 37 CFR §§1.56 and 1.97, the attention of the Examiner is directed to the documents listed on the attached Form PTO-1449. Copies of the listed documents are attached. Neither this Statement nor the listing of these documents on Form PTO-1449 is an admission that these documents are prior art as to the Applicants or a representation that a search has been made or that no more pertinent documents exist.

Of these documents, documents AF and AN were cited in the International Search Report issued in the international stage of the present application. A copy of the search report is attached as an explanation of the relevance of those documents. The remaining documents are discussed in paragraph 011 of the present

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application as filed. Document AK is a published utility model application, so an English abstract of that document is not available.

The Applicants respectfully request that the listed documents be considered by the Examiner and made of record in the referenced patent application.

Respectfully submitted,



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Form PTO-1449 (modified) List of Patent and Publications For Applicant's Information Disclosure Statement (use several sheets if necessary)	Atty. Docket. No.:	1088 019498
	Intl. Appln. No.:	
	Applicant: Takayuki Nikaido et al	
Page 1 of 1	Intl. Filing Date:	Art Unit:
	December 27, 2004	

U.S. PATENT DOCUMENTS

Exr's Initial		Document No.							Date	Name	Class	Sub class	Filing Date
	AA												
	AB												
	AC												
	AD												
	AE												

FOREIGN PATENT DOCUMENTS

		Document No.							Date	Country	Class	Sub class	Translation	
													Yes No	
	AF	01	3	0	5	5	9	4	12/8/89	JP				Abstract
	AG	04	0	1	3	4	7	4	1/17/92	JP				Abstract
	AH	04	0	4	6	6	6	7	2/17/92	JP				Abstract
	AI	04	2	5	1	6	6	1	9/8/92	JP				Abstract
	AJ	05	0	9	3	0	7	9	12/17/93	JP				no
	AK	05	0	5	0	2	1	8	3/2/93	JP				Abstract
	AL	09	3	0	7	2	2	4	11/28/97	JP				Abstract
	AM	10	3	3	5	8	0	7	12/18/98	JP				Abstract
	AN	2000	0	4	0	8	7	4	2/8/00	JP				Abstract
	AO													

OTHER ART (Including author, title, date pertinent pages, etc.)

	AP	
	AQ	
	AR	

Examiner	Date considered:
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EXAMINER: Initial if reference considered, no matter whether citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.